Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/008,456	OWENS ET AL.	
Examiner	Art Unit	
Baisakhi Roy	3737	

	SEAR	CHED	•
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Class	Subclass	Date	Examiner
600	407, 427, 429, 439	2/23/2007	BR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see attached search history	2/23/2007	BR		